


<b>Search Notes</b>  	<b>Application/Control No.</b>  10823568	<b>Applicant(s)/Patent Under Reexamination</b>  TANAKA ET AL.
	<b>Examiner</b>  Nguyen, Cuong Q	<b>Art Unit</b>  2811

SEARCHED			
Class	Subclass	Date	Examiner
257	314-324	04-14-07	CN
257	678-681	04-14-07	CN

SEARCH NOTES			
Search Notes		Date	Examiner
EAST, EPO, JPO		04-14-07	CN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
See search note			